Low-ohmic single-pole double-throw analog switch Rev. 10.1 — 24 November 2020 Produc

Product data sheet

1 General description

The NX3L1G3157 is a low-ohmic single-pole double-throw analog switch suitable for use as an analog or digital 2:1 multiplexer/demultiplexer. It has a digital select input (S), two independent inputs/outputs (Y0 and Y1) and a common input/output (Z). Schmitt trigger action at the digital input makes the circuit tolerant to slower input rise and fall times.

The NX3L1G3157 allows signals with amplitude up to V_{CC} to be transmitted from Z to Y0 or Y1; or from Y0 or Y1 to Z. Its low ON resistance (0.5 Ω) and flatness (0.13 Ω) ensures minimal attenuation and distortion of transmitted signals.

2 Features and benefits

- Wide supply voltage range from 1.4 V to 4.3 V
- Very low ON resistance:
 - 1.6 Ω (typical) at V_{CC} = 1.4 V
 - 1.0 Ω (typical) at V_{CC} = 1.65 V
 - 0.55 Ω (typical) at V_{CC} = 2.3 V
 - 0.50 Ω (typical) at V_{CC} = 2.7 V
 - 0.50 Ω (typical) at V_{CC} = 4.3 V
- Break-before-make switching
- High noise immunity
- ESD protection:
 - HBM JESD22-A114F Class 3A exceeds 7500 V
 - MM JESD22-A115-A exceeds 200 V
 - CDM AEC-Q100-011 revision B exceeds 1000 V
 - IEC61000-4-2 contact discharge exceeds 8000 V for switch ports
- CMOS low-power consumption
- Latch-up performance exceeds 100 mA per JESD78 Class II Level A
- Direct interface with TTL levels at 3.0 V
- · Control input accepts voltages above supply voltage
- High current handling capability (350 mA continuous current under 3.3 V supply)
- Specified from -40 $^\circ\text{C}$ to +85 $^\circ\text{C}$ and from -40 $^\circ\text{C}$ to +125 $^\circ\text{C}$

3 Applications

- Cell phone
- PDA
- · Portable media player



Low-ohmic single-pole double-throw analog switch

Ordering information 4

Table 1. Ordering information									
Type number	Topside	Package	Package						
	marking ^[1]	Name	Description	Version					
NX3L1G3157GM	MJ	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 x 1.45 x 0.5 mm	SOT886					

[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

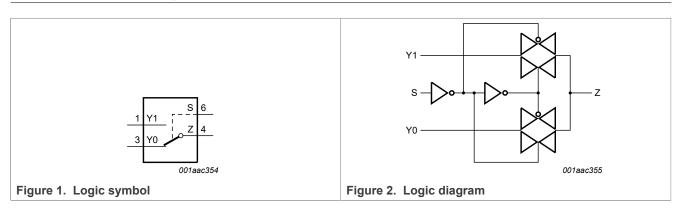
4.1 Ordering options

Table 2. Ordering options

Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature
NX3L1G3157GM	NX3L1G3157GM,115 ^[1]	XSON6	REEL 7" Q1 NDP	5000	T _{amb} = -40 °C to +125 °C
NX3L1G3157GM	NX3L1G3157GMZ	XSON6	REEL 7" Q1 NDP SSB ^[2]	5000	T_{amb} = -40 °C to +125 °C

Will go EOL - migrate to new leadframe NX3L1G3157GMZ orderable part number This packing method uses a Static Shielding Bag (SSB) solution. Material is to be kept in the sealed bag between uses. [1] [2]

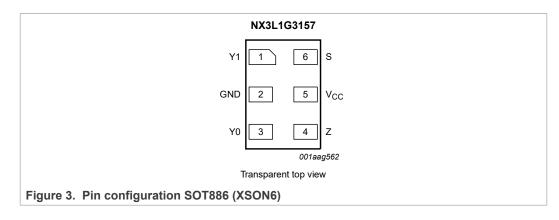
Functional diagram 5



Pinning information 6

Low-ohmic single-pole double-throw analog switch

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description	
Y1	1	independent input or output	
GND	2	ound (0 V)	
Y0	3	independent input or output	
Z	4	common output or input	
V _{CC}	5	supply voltage	
S	6	select input	

7 Functional description

Table 4. Function table^[1]

Input S	Channel on
L	Y0
Н	Y1

[1] H = HIGH voltage level; L = LOW voltage level.

8 Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+4.6	V
VI	input voltage	select input S	[1]	-0.5	+4.6	V
V _{SW}	switch voltage		[2]	-0.5	V _{CC} + 0.5	V
I _{IK}	input clamping current	V ₁ < -0.5 V		-50	-	mA
I _{SK}	switch clamping current	$V_{\rm I}$ < -0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V		-	±50	mA

Low-ohmic single-pole double-throw analog switch

Table 5. Limiting values...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Мах	Unit
I _{SW}	switch current	V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; source or sink current		-	±350	mA
		V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; pulsed at 1 ms duration, < 10 % duty cycle; peak current		-	±500	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C	[3]	-	250	mW

[1] The minimum input voltage rating may be exceeded if the input current rating is observed.

[2] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed but may not exceed 4.6 V.

[3] For XSON6 package: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

9 Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			1.4	4.3	V
VI	input voltage	select input S		0	4.3	V
V _{SW}	switch voltage		[1]	0	V _{CC}	V
T _{amb}	ambient temperature			-40	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.4 V to 4.3 V	[2]	-	200	ns/V

[1] To avoid sinking GND current from terminal Z when switch current flows in terminal Yn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no GND current flows from terminal Yn. In this case, there is no limit for the voltage drop across the switch.

[2] Applies to control signal levels.

10 Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	T _{ar}	_{nb} = 25	°C	T _{amb} =	Unit		
			Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)	
V _{IH}	HIGH-level	V _{CC} = 1.4 V to 1.95 V	0.65V _{CC}	-	-	$0.65V_{CC}$	-	-	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	-	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	-	V
		V _{CC} = 3.6 V to 4.3 V	0.7V _{CC}	-	-	0.7V _{CC}	-	-	V
V _{IL}	LOW-level	V _{CC} = 1.4 V to 1.95 V	-	-	$0.35V_{CC}$	-	$0.35V_{CC}$	$0.35V_{CC}$	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	0.7	0.7	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	0.8	V
		V _{CC} = 3.6 V to 4.3 V	-	-	0.3V _{CC}	-	0.3V _{CC}	0.3V _{CC}	V
I	input leakage current	select input S; V_1 = GND to 4.3 V; V_{CC} = 1.4 V to 4.3 V	-	-	-	-	±0.5	±1	μA
NX3L1G3157		All information provided in t	this document is subject	to legal discl	aimers.	1	© NXP	B.V. 2020. All righ	ts reserved

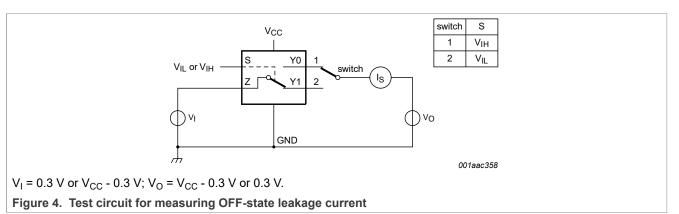
Low-ohmic single-pole double-throw analog switch

Table 7. Static characteristics...continued

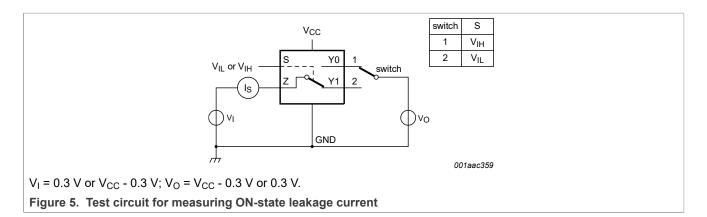
At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	Ta	T _{amb} = 25 °C			T _{amb} = -40 °C to +125 °C			
			Min	Тур	Мах	Min	Max (85 °C)	Max (125 °C)		
I _{S(OFF)}	leakage	Y0 and Y1 port; see Figure 4								
	current	V _{CC} = 1.4 V to 3.6 V	-	-	±5	-	±50	±500	nA	
		V _{CC} = 3.6 V to 4.3 V	-	-	±10	-	±50	±500	nA	
I _{S(ON)}	I _{S(ON)} ON-state leakage current	Z port; see Figure 5								
		V _{CC} = 1.4 V to 3.6 V	-	-	±5	-	±50	±500	nA	
		V _{CC} = 3.6 V to 4.3 V	-	-	±10	-	±50	±500	nA	
I _{CC}	supply current	$V_{I} = V_{CC}$ or GND; $V_{SW} =$ GND or V_{CC}								
		V _{CC} = 3.6 V	-	-	100	-	690	6000	nA	
		V _{CC} = 4.3 V	-	-	150	-	800	7000	nA	
CI	input capacitance		-	1.0	-	-	-	-	pF	
C _{S(OFF)}	OFF-state capacitance		-	35	-	-	-	-	pF	
C _{S(ON)}	ON-state capacitance		-	130	-	-	-	-	pF	

10.1 Test circuits



Low-ohmic single-pole double-throw analog switch



10.2 ON resistance

Table 8. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see Figure 7 to Figure 13.

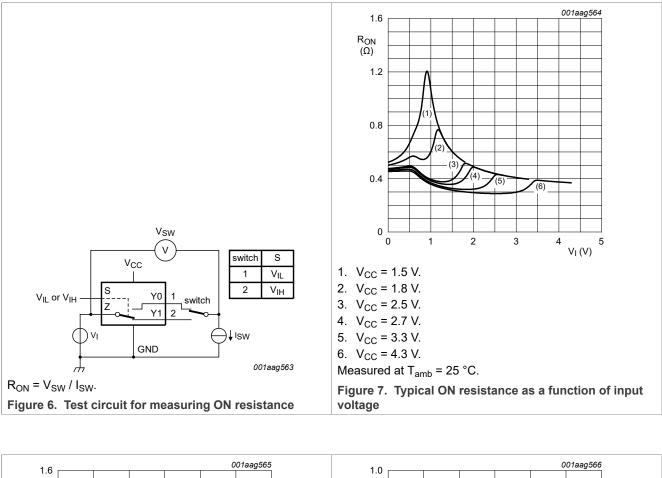
Symbol	Parameter	Conditions		T _{amb} =	-40 °C to	+85 °C	T _{amb} = -40 °	Unit	
				Min	Typ ^[1]	Мах	Min	Max	
R _{ON(peak)}	ON resistance (peak)	V_{I} = GND to V_{CC} ; I_{SW} = 100 mA; see <u>Figure 6</u>							
		V _{CC} = 1.4 V		-	1.6	3.7	-	4.1	Ω
		V _{CC} = 1.65 V		-	1.0	1.6	-	1.7	Ω
		V _{CC} = 2.3 V		-	0.55	0.8	-	0.9	Ω
		V _{CC} = 2.7 V		-	0.5	0.75	-	0.9	Ω
		V _{CC} = 4.3 V		-	0.5	0.75	-	0.9	Ω
ΔR _{ON} ON resistance mismatch between	$V_I = GND$ to V_{CC} ; $I_{SW} = 100 \text{ mA}$	[2]							
	channels	V _{CC} = 1.4 V		-	0.04	0.3	-	0.3	Ω
		V _{CC} = 1.65 V		-	0.04	0.2	-	0.3	Ω
		V _{CC} = 2.3 V		-	0.02	0.08	-	0.1	Ω
		V _{CC} = 2.7 V		-	0.02	0.075	-	0.1	Ω
		V _{CC} = 4.3 V		-	0.02	0.075	-	0.1	Ω
R _{ON(flat)}	ON resistance (flatness)	$V_I = GND$ to V_{CC} ; $I_{SW} = 100 \text{ mA}$	[3]						
		V _{CC} = 1.4 V		-	1.0	3.3	-	3.6	Ω
		V _{CC} = 1.65 V		-	0.5	1.2	-	1.3	Ω
		V _{CC} = 2.3 V		-	0.15	0.3	-	0.35	Ω
		V _{CC} = 2.7 V		-	0.13	0.3	-	0.35	Ω
		V _{CC} = 4.3 V		-	0.2	0.4	-	0.45	Ω

[1]

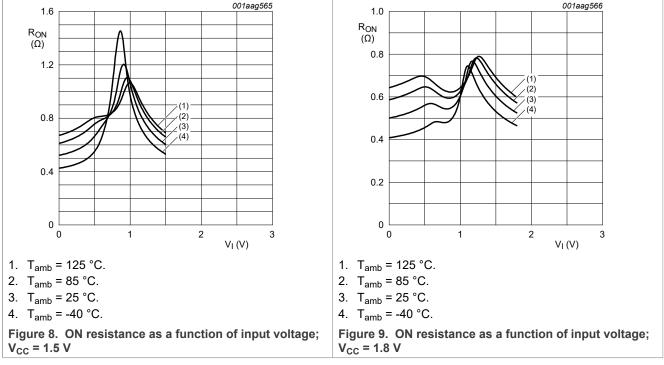
[2] [3]

Typical values are measured at $T_{amb} = 25$ °C. Measured at identical V_{CC}, temperature and input voltage. Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical V_{CC} and temperature.

Low-ohmic single-pole double-throw analog switch



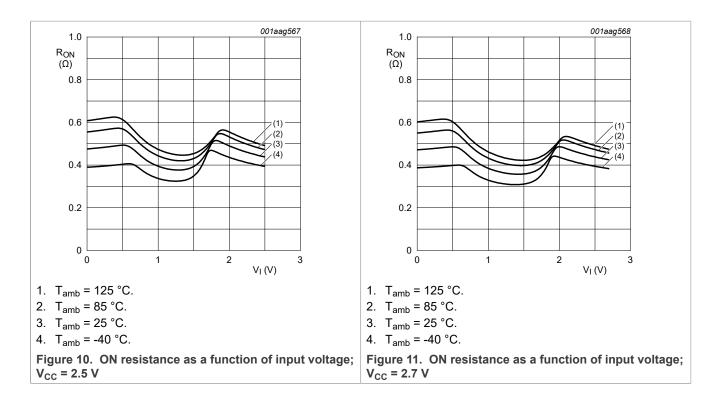
10.3 ON resistance test circuit and graphs

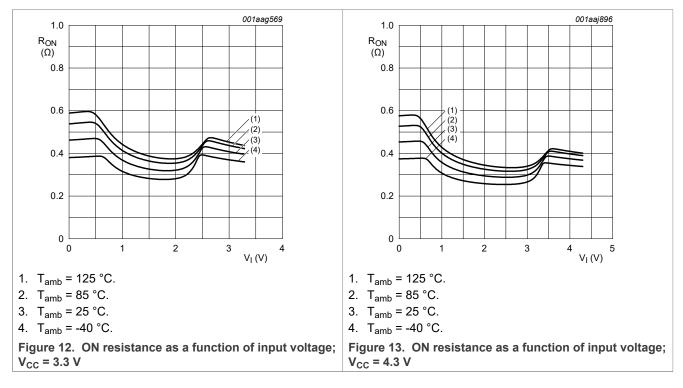


© NXP B.V. 2020. All rights reserved.

NX3L1G3157

Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch

11 Dynamic characteristics

Table 9. Dynamic characteristics

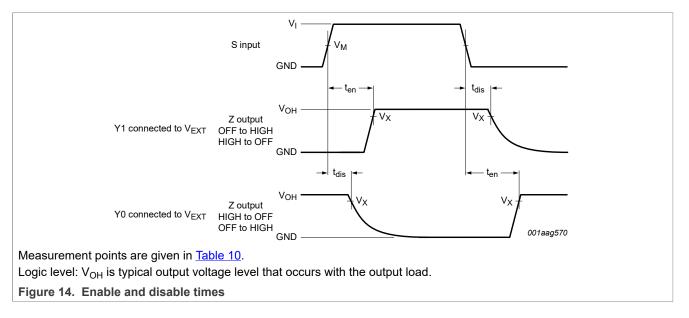
At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for load circuit see Figure 16.

Symbol	Parameter	Conditions		Т	_{amb} = 25 °	°C	T _{amb} =	= -40 °C to +	+125 °C	Unit
				Min	Тур ^[1]	Max	Min	Max (85 °C)	Max (125 °C)	
t _{en}	enable time	S to Z or Yn; see Figure 14								
		V _{CC} = 1.4 V to 1.6 V		-	28	43	-	48	52	ns
		V_{CC} = 1.65 V to 1.95 V		-	23	35	-	38	42	ns
		V _{CC} = 2.3 V to 2.7 V		-	17	27	-	29	32	ns
		V _{CC} = 2.7 V to 3.6 V		-	14	25	-	27	30	ns
		V _{CC} = 3.6 V to 4.3 V		-	14	25	-	27	30	ns
t _{dis}	disable time	S to Z or Yn; see Figure 14								
		V _{CC} = 1.4 V to 1.6 V		-	9	20	-	25	30	ns
		V_{CC} = 1.65 V to 1.95 V		-	6	15	-	20	23	ns
		V _{CC} = 2.3 V to 2.7 V		-	5	11	-	14	16	ns
		V _{CC} = 2.7 V to 3.6 V		-	4	10	-	12	14	ns
		V _{CC} = 3.6 V to 4.3 V		-	4	10	-	12	14	ns
t _{b-m}	break-before-make	see Figure 15	[2]							
	time	V _{CC} = 1.4 V to 1.6 V		-	19	-	4	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		-	17	-	4	-	-	ns
		V _{CC} = 2.3 V to 2.7 V		-	13	-	2	-	-	ns
		V _{CC} = 2.7 V to 3.6 V		-	10	-	2	-	-	ns
		V _{CC} = 3.6 V to 4.3 V		-	10	-	2	-	-	ns

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.5 V, 1.8 V, 2.5 V, 3.3 V and 4.3 V respectively.

[2] Break-before-make guaranteed by design.

Low-ohmic single-pole double-throw analog switch

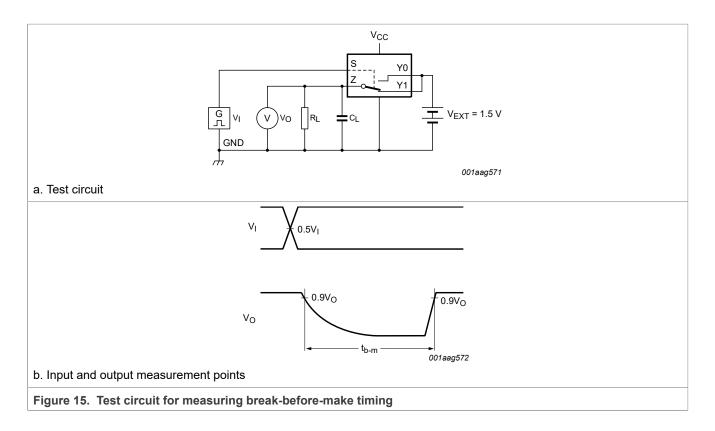


11.1 Waveform and test circuits

Table 10. Measurement points

Supply voltage	Input	Output
V _{cc}	V _M	V _X
1.4 V to 4.3 V	0.5V _{CC}	0.9V _{OH}

Low-ohmic single-pole double-throw analog switch



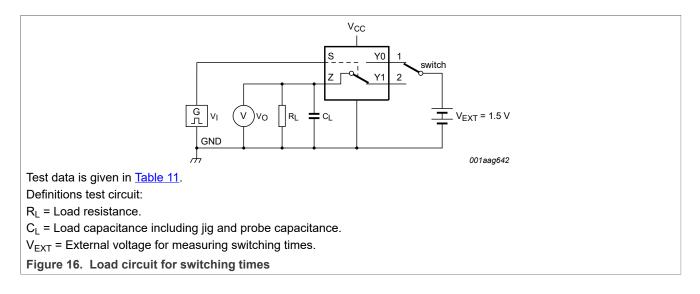


Table 11. Test data

Supply voltage	Input		Load	
V _{cc}	VI	t _r , t _f	CL	RL
1.4 V to 4.3 V	V _{CC}	≤ 2.5 ns	35 pF	50 Ω

NX3L1G3157 Product data sheet © NXP B.V. 2020. All rights reserved.

Low-ohmic single-pole double-throw analog switch

11.2 Additional dynamic characteristics

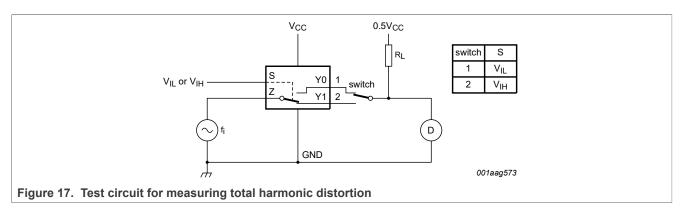
Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $V_I = GND$ or V_{CC} (unless otherwise specified); $t_r = t_f \le 2.5$ ns; $T_{amb} = 25$ °C.

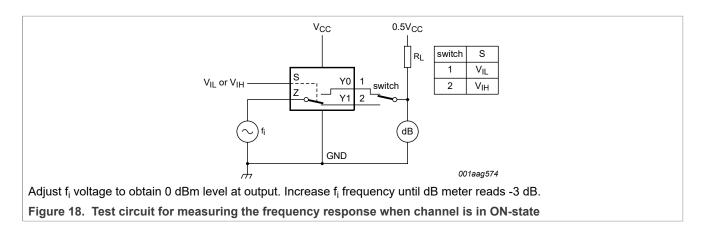
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
	total harmonic	f_i = 20 Hz to 20 kHz; R_L = 32 Ω; see Figure 17	[1]				
	distortion	V _{CC} = 1.4 V; V _I = 1 V (p-p)		-	0.15	-	%
		V _{CC} = 1.65 V; V _I = 1.2 V (p-p)		-	0.10	-	%
		V _{CC} = 2.3 V; V _I = 1.5 V (p-p)		-	0.02	-	%
		V _{CC} = 2.7 V; V _I = 2 V (p-p)		-	0.02	-	%
		V _{CC} = 4.3 V; V _I = 2 V (p-p)		-	0.02	-	%
f _(-3dB)	-3 dB frequency	R_L = 50 Ω; see <u>Figure 18</u>	[1]				
	response	V _{CC} = 1.4 V to 4.3 V		-	60	-	MHz
α_{iso} isolation (OFF-state)	isolation (OFF-state)	f_i = 100 kHz; R_L = 50 Ω ; see <u>Figure 19</u>	[1]				
		V _{CC} = 1.4 V to 4.3 V		-	-90	-	dB
V _{ct} crosstalk voltage	crosstalk voltage	between digital inputs and switch; f _i = 1 MHz; C _L = 50 pF; R _L = 50 Ω ; see Figure 20					
		V _{CC} = 1.4 V to 3.6 V		-	0.2	-	V
		V _{CC} = 3.6 V to 4.3 V		-	0.3	-	V
Q _{inj} charge injection	charge injection	f_i = 1 MHz; C _L = 0.1 nF; R _L = 1 MΩ; V _{gen} = 0 V; R _{gen} = 0 Ω; see Figure 21					
		V _{CC} = 1.5 V		-	3	-	рС
		V _{CC} = 1.8 V		-	4	-	рС
		V _{CC} = 2.5 V		-	6	-	рС
		V _{CC} = 3.3 V		-	9	-	рС
		V _{CC} = 4.3 V		-	15	-	рС

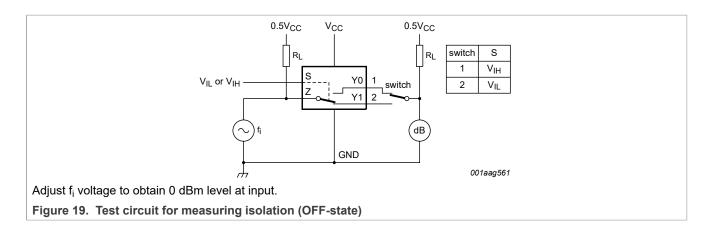
[1] f_i is biased at 0.5V_{CC}.

11.3 Test circuits

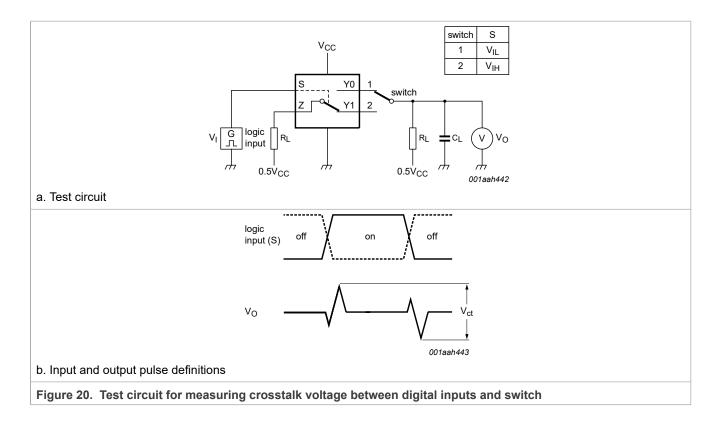


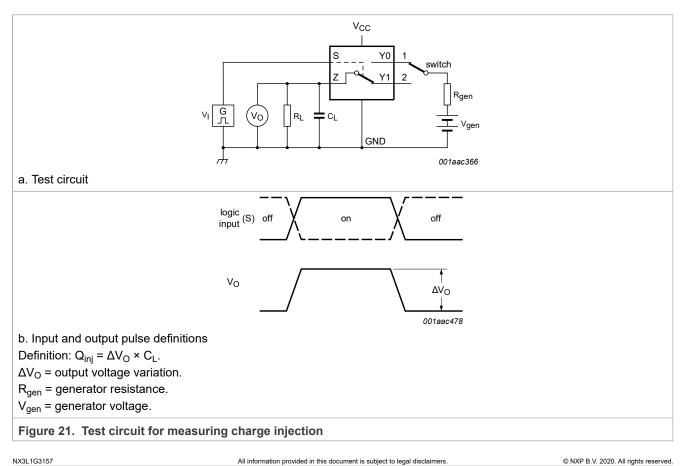
Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch





Low-ohmic single-pole double-throw analog switch

12 Package outline

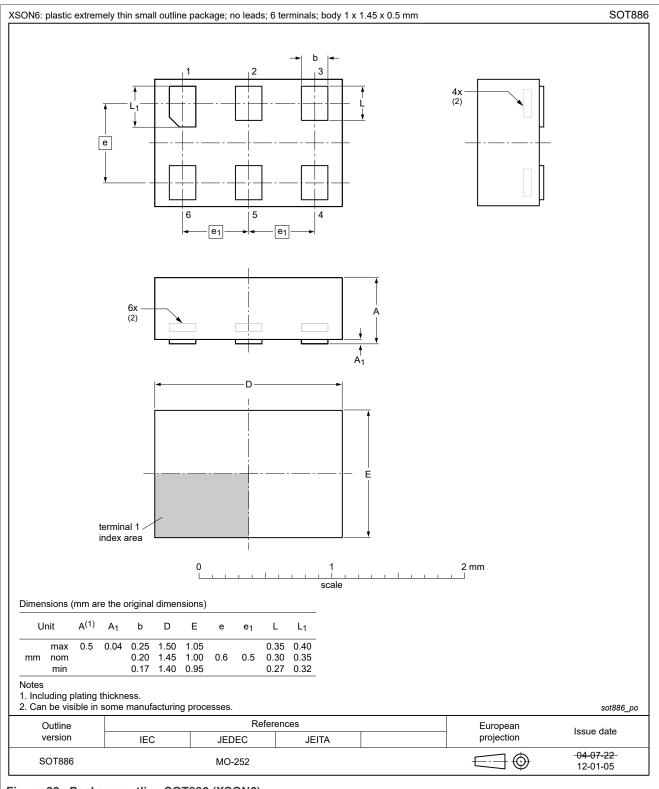


Figure 22. Package outline SOT886 (XSON6)

Low-ohmic single-pole double-throw analog switch

13 Abbreviations

Table 13. Abbreviations			
Acronym	Description		
CDM	Charged Device Model		
CMOS	Complementary Metal-Oxide Semiconductor		
ESD	ElectroStatic Discharge		
НВМ	Human Body Model		
ММ	Machine Model		
PDA	Personal Digital Assistant		
TTL	Transistor-Transistor Logic		

14 Revision history

Table 14. Revision his	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
NX3L1G3157 v.10.1	20201124	Product data sheet	-	NX3L1G3157 v.10
Modifications:	Assembly/Test	886 requiring SSB added. Refe Transfer from ATGD and ATSI L1G3157GW,125		1909001 XSON6 (SOT886
NX3L1G3157 v.10	20120807	Product data sheet	-	NX3L1G3157 v.9
Modifications:	 Package outling 	e drawing of SOT886 (Figure 2	22) modified.	
NX3L1G3157 v.9	20111109	Product data sheet	-	NX3L1G3157 v.8
Modifications:	 Legal pages u 	pdated.	·	
NX3L1G3157 v.8	20100426	Product data sheet	-	NX3L1G3157 v.7
NX3L1G3157 v.7	20100324	Product data sheet	-	NX3L1G3157 v.6
NX3L1G3157 v.6	20100208	Product data sheet	-	NX3L1G3157 v.5
NX3L1G3157 v.5	20090407	Product data sheet	-	NX3L1G3157 v.4
NX3L1G3157 v.4	20080730	Product data sheet	-	NX3L1G3157 v.3
NX3L1G3157 v.3	20080721	Product data sheet	-	NX3L1G3157 v.2
NX3L1G3157 v.2	20080415	Product data sheet	-	NX3L1G3157 v.1
NX3L1G3157 v.1	20071008	Product data sheet	-	-

Low-ohmic single-pole double-throw analog switch

15 Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

15.2 Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

15.3 Disclaimers

Limited warranty and liability - Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors. In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory. Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXF Semiconductors

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without

notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

 $\ensuremath{\mathsf{Applications}}$ — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification. Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products. NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

Low-ohmic single-pole double-throw analog switch

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications. In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for

such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

15.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

Low-ohmic single-pole double-throw analog switch

Tables

Tab. 1.	Ordering information	2
Tab. 2.	Ordering options	2
Tab. 3.	Pin description	3
Tab. 4.	Function table	3
Tab. 5.	Limiting values	3
Tab. 6.	Recommended operating conditions	4
Tab. 7.	Static characteristics	4

Figures

Fig. 1.	Logic symbol	2
Fig. 2.	Logic diagram	
Fig. 3.	Pin configuration SOT886 (XSON6)	
Fig. 4.	Test circuit for measuring OFF-state	
	leakage current	5
Fig. 5.	Test circuit for measuring ON-state leakage	
	current	
Fig. 6.	Test circuit for measuring ON resistance	.7
Fig. 7.	Typical ON resistance as a function of input	
	voltage	.7
Fig. 8.	ON resistance as a function of input	
	voltage; VCC = 1.5 V	.7
Fig. 9.	ON resistance as a function of input	
	voltage; VCC = 1.8 V	.7
Fig. 10.	ON resistance as a function of input	
	voltage; VCC = 2.5 V	.8
Fig. 11.	ON resistance as a function of input	
	voltage; VCC = 2.7 V	.8

Tab. 8.	ON resistance	6
Tab. 9.	Dynamic characteristics	9
Tab. 10.	Measurement points	10
Tab. 11.	Test data	11
Tab. 12.	Additional dynamic characteristics	12
Tab. 13.	Abbreviations	16
Tab. 14.	Revision history	16

Fig. 12.	ON resistance as a function of input	
	voltage; VCC = 3.3 V	8
Fig. 13.	ON resistance as a function of input	
	voltage; VCC = 4.3 V	8
Fig. 14.	Enable and disable times	10
Fig. 15.	Test circuit for measuring break-before-	
U U	make timing	11
Fig. 16.	Load circuit for switching times	11
Fig. 17.	Test circuit for measuring total harmonic	
	distortion	12
Fig. 18.	Test circuit for measuring the frequency	
-	response when channel is in ON-state	13
Fig. 19.	Test circuit for measuring isolation (OFF-	
U U	state)	13
Fig. 20.	Test circuit for measuring crosstalk voltage	
•	between digital inputs and switch	14
Fig. 21.	Test circuit for measuring charge injection	
Fig. 22.	Package outline SOT886 (XSON6)	
-	5	

Low-ohmic single-pole double-throw analog switch

Contents

General description	1
Ordering information	2
Ordering options	2
Functional diagram	2
Functional description	3
Static characteristics	4
Test circuits	5
ON resistance	6
ON resistance test circuit and graphs	7
Dynamic characteristics	9
Waveform and test circuits	10
Additional dynamic characteristics	12
Package outline	15
Revision history	16
Legal information	17
	General description Features and benefits Applications Ordering information Ordering options Functional diagram Pinning information Pin description Functional description Functional description Imiting values Recommended operating conditions Static characteristics Test circuits ON resistance test circuit and graphs Dynamic characteristics Waveform and test circuits Additional dynamic characteristics Test circuits Package outline Abbreviations Revision history Legal information

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2020.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 24 November 2020 Document identifier: NX3L1G3157

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

NXP:

NX3L1G3157GM-Q100X NX3L1G3157GW-Q100H